Notice of References Cited	Application/Control No. 10/679,896	Applicant(s)/Patent Under Reexamination WEIS ET AL.	
	Examiner Vu Le	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0030688	10-2001	Asahi et al.	348/118
	B	US-2005/0033495 A1	02-2005	Tanaka et al.	701/036
	C	US-			
	D	US-2003/0122687 A1	07-2003	Trajkovic et al.	340/932.2
	E	US-6,657,555 B2	12-2003	Shimizu et al.	340/932.2
	F	US-2003/0045973 A1	03-2003	Okamoto, Shinichi	701/1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.